Search Notes		
	OHIOI OIRID OHII ILEID	

5	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/656,721	PANG ET AL.	
	Examiner	Art Unit	
	M. Franco Salvoza	1648	

SEARCHED			
Class	Subclass	Date	Examiner
424	218.1	9/26/2006	MFS
	199.1	9/26/2006	MFS
	204.1	9/26/2006	MFS
	186.1	9/26/2006	MFS
	202.1	9/26/2006	MFS
	93.2	9/26/2006	MFS
435	5	9/26/2006	MFS
	235.1	9/26/2006	MFS
	320.1	9/26/2006	MFS
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NO (INCLUDING SEARCH)
•	DATE	EXMR
WEST (US-PGPUB; USPAT; EPO; JPO; DERWENT) (see attached results)	9/26/2006	MFS
PUBMED (see attached results)	9/26/2006	MFS
Inventor Search (PALM)	9/26/2006	MFS
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